

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4060

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm $(\mu V/(V/m)^2)$	0.79	0.74	1.28	± 10.1 %
DCP (mV) ^B	98.2	95.5	93.6	

Calibration results for Frequency Response (30 MHz - 6 GHz)

Frequency MHz	Target E-Field V/m	Measured E-field (En) V/m	Deviation E-normal in %	Measured E-field (Ep) V/m	Deviation E-normal in %	Unc (k=2) %
30	77.2	77.3	0.2%	77.4	0.3%	± 5.1 %
100	77.3	78.3	1.3%	78.6	1.7%	± 5.1 %
450	77.1	78.1	1.3%	78.2	1.4%	± 5.1 %
600	77.1	77.6	0.7%	77.6	0.7%	± 5.1 %
750	77.2	77.6	0.5%	77.4	0.3%	± 5.1 %
1800	143.1	139.1	-2.8%	139.3	-2.6%	± 5.1 %
2000	135.1	131.5	-2.6%	131.6	-2.6%	± 5.1 %
2200	127.5	123.4	-3.2%	124.8	-2.1%	± 5.1 %
2500	125.5	122.5	-2.3%	123.6	-1.5%	± 5.1 %
3000	79.4	75.9	-4.5%	76.8	-3.3%	± 5.1 %
3500	256.2	247.1	-3.5%	244.6	-4.5%	± 5.1 %
3700	249.5	238.4	-4.4%	237.2	-4.9%	± 5.1 %
5200	50.7	51.2	0.9%	51.5	1.6%	± 5.1 %
5500	49.7	49.4	-0.6%	48.2	-3.0%	± 5.1 %
5800	48.8	48.7	-0.3%	49.6	1.6%	± 5.1 %

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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B Numerical linearization parameter: uncertainty not required.

E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the



EF3DV3 - SN:4060

May 17, 2019

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Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dBõV	С	D dB	VR mV	Max dev.	Max Unc ^E (k=2)
0 CW	CW	X	0.00	0.00	1.00	0.00	171.1	± 3.5 %	± 4.7 %
		Y	0.00	0.00	1.00		164.2		
		Z	0.00	0.00	1.00	1	172.8	1	
10352-	Pulse Waveform (200Hz, 10%)	X	2.72	65.67	9.66	10.00	60.0	± 3.2 %	± 9.6 %
AAA		Y	6.00	74.00	13.00		60.0		
		Z	2.66	66.07	9.64		60.0		
10353-	Pulse Waveform (200Hz, 20%)	X	1.27	62.48	7.17	6.99	80.0	± 1.3 %	± 9.6 %
AAA	200	Y	1.38	63.43	7.77		80.0		200 GROSE 200
		Z	1.30	63.08	7.35		80.0		
10354-	Pulse Waveform (200Hz, 40%)	X	0.57	60.93	5.43	3.98	95.0	± 0.9 %	± 9.6 %
AAA		Y	0.70	62.08	6.24		95.0		
		Z	0.61	61.44	5.61		95.0		
10355-	Pulse Waveform (200Hz, 60%)	X	0.31	60.48	4.52	2.22	120.0	± 0.9 %	± 9.6 %
AAA		Y	0.35	60.82	4.90		120.0		
		Z	0.42	61.46	4.70		120.0	1	
10387-	QPSK Waveform, 1 MHz	X	0.52	60.58	6.63	0.00	150.0	± 2.6 %	± 9.6 %
AAA	*	Y	0.46	60.00	5.71		150.0		100000000000000000000000000000000000000
		Z	0.44	60.00	5.37		150.0		
10388-	QPSK Waveform, 10 MHz	X	2.47	70.93	17.56	0.00	150.0	± 1.0 %	± 9.6 %
AAA		Y	2.22	69.08	16.44		150.0		STATE OF SEC.
		Z	2.44	71.07	17.65		150.0		
10396-	64-QAM Waveform, 100 kHz	X	1.74	65.32	17.52	3.01	150.0	± 3.3 %	± 9.6 %
AAA		Y	1.82	65.53	17.41		150.0		
	1	Z	2.13	67.57	17.98		150.0		
10399-	64-QAM Waveform, 40 MHz	X	3.57	67.84	16.46	0.00	150.0	± 1.8 %	± 9.6 %
AAA		Y	3.41	67.03	15.92		150.0		,,,
		Z	3.54	67.84	16.52		150.0		
10414-	WLAN CCDF, 64-QAM, 40MHz	X	4.80	66.13	16.05	0.00	150.0	± 3.4 %	± 9.6 %
AAA	20 July 20 Jul	Y	4.67	65.67	15.72		150.0		
		Z	4.77	66.19	16.15		150.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: EF3-4060_May19

B Numerical linearization parameter: uncertainty not required.

E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



DASY/EASY - Parameters of Probe: EF3DV3 - SN:4060

Sensor Frequency Model Parameters

	Sensor X	Sensor Y	Sensor Z
Frequency Corr. (LF)	0.22	0.21	4.59
Frequency Corr. (HF)	2.82	2.82	2.82

Sensor Model Parameters

	C1 fF	C2 fF	α V ⁻¹	T1 ms.V ⁻²	T2 ms.V ⁻¹	T3 ms	T4 V ⁻²	T5 V ⁻¹	Т6
X	36.7	244.56	37.42	5.96	0.18	4.95	0.00	0.00	1.01
Y	35.1	235.07	37.62	8.08	0.00	4.99	0.00	0.06	1.01
Z	33.6	228.28	38.82	7.28	0.00	4.99	0.00	0.19	1.00

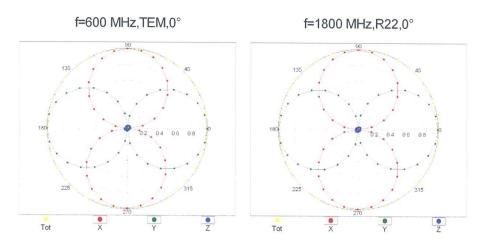
Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	-36.4
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	12 mm
Tip Length	25 mm
Tip Diameter	4 mm
Probe Tip to Sensor X Calibration Point	1.5 mm
Probe Tip to Sensor Y Calibration Point	1.5 mm
Probe Tip to Sensor Z Calibration Point	1.5 mm

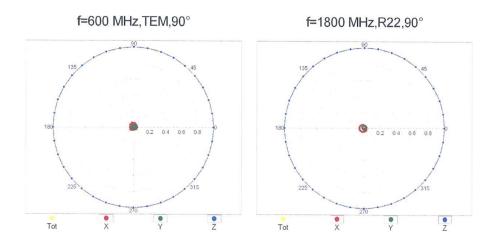
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Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$

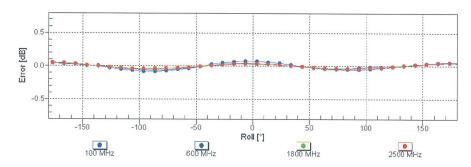


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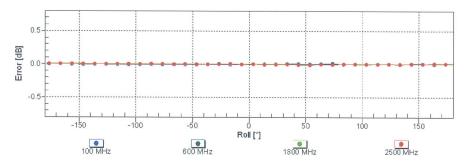


Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$



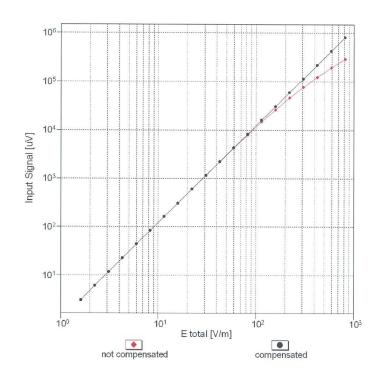
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

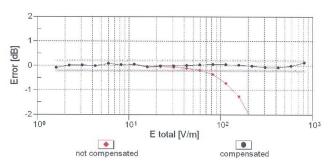
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Dynamic Range f(E-field) (TEM cell, f = 900 MHz)





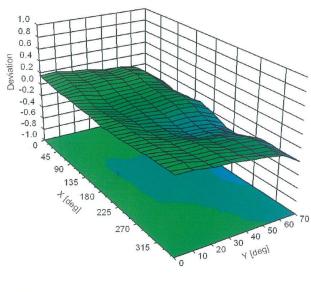
Uncertainty of Linearity Assessment: ± 0.6% (k=2)

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Deviation from Isotropy in Air Error (φ, θ), f = 900 MHz





Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

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ANNEX E DIPOLE CALIBRATION CERTIFICATE

Dipole 835 MHz

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Client

CTTL (Auden)

Certificate No: CD835V3-1023 Aug18

August 28, 2018 s the traceability to nati	edure for dipoles in air	nd are part of the certificate.
Calibration process August 28, 2018 s the traceability to natinities with confidence p d in the closed laborator critical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k)	ional standards, which realize the physical unprobability are given on the following pages are ry facility: environment temperature (22 ± 3)°0 Cal Date (Certificate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02673)	C and humidity < 70%. Scheduled Calibration Apr-19 Apr-19 Apr-19
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	04-Apr-18 (No. 217-02683)	Apr-19
SN: 4013	05-Mar-18 (No. EF3-4013_Mar18)	Mar-19
SN: 781	17-Jan-18 (No. DAE4-781_Jan18)	Jan-19
ID#	Check Date (in house)	Scheduled Check
SN: GB42420191	William To Committee of the Committee of	In house check: Oct-20
	,	In house check: Oct-20
SN: US37295597	10 mm	In house check: Oct-20
SN: 832283/011		In house check: Oct-20
SN: US41080477	31-Mar-14 (in house check Oct-17)	In house check: Oct-20
Name	Function	Signature
Leif Klysner	Laboratory Technician	Sed Illa
Katja Pokovic	Technical Manager	Sed The
L	ID # SN: GB42420191 SN: US38485102 SN: US37295597 SN: 832283/011 SN: US41080477 Name Leif Klysner	ID # Check Date (in house) SN: GB42420191

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

References

 ANSI-C63.19-2011
 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna
 (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes.
 In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a
 distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.1
Phantom	HAC Test Arch	200000
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 835 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	111.0 V/m = 40.91 dBV/m
Maximum measured above low end	100 mW input power	109.6 V/m = 40.80 dBV/m
Averaged maximum above arm	100 mW input power	110.3 V/m ± 12.8 % (k=2)

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	18.1 dB	42.6 Ω - 9.0 jΩ
835 MHz	23.3 dB	$53.6 \Omega + 6.1 j\Omega$
880 MHz	15.6 dB	65.0 Ω - 11.8 jΩ
900 MHz	17.7 dB	53.6 Ω - 13.1 jΩ
945 MHz	25.0 dB	$46.5 \Omega + 4.1 j\Omega$

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

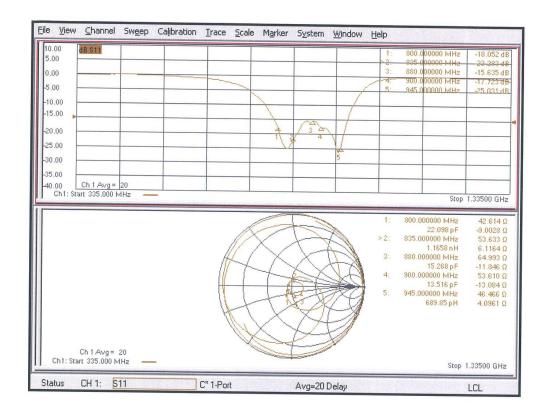
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot





DASY5 E-field Result

Date: 28.08.2018

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1023

Communication System: UID 0 - CW ; Frequency: 835 MHz Medium parameters used: $\sigma=0$ S/m, $\epsilon_r=1$; $\rho=0$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EF3DV3 SN4013; ConvF(1, 1, 1) @ 835 MHz; Calibrated: 05.03.2018
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 17.01.2018
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.1(1476); SEMCAD X 14.6.11(7439)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test (41x361x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 132.3 V/m; Power Drift = -0.03 dB

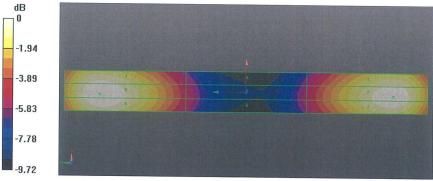
Applied MIF = 0.00 dB

RF audio interference level = 40.91 dBV/m

Emission category: M3

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
40.37 dBV/m	40.8 dBV/m	40.73 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
35.58 dBV/m	35.93 dBV/m	35.91 dBV/m
Grid 7 M3	Grid 8 M3	Grid 9 M3
40.56 dBV/m	40.91 dBV/m	40.85 dBV/m



0 dB = 111.0 V/m = 40.91 dBV/m

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